

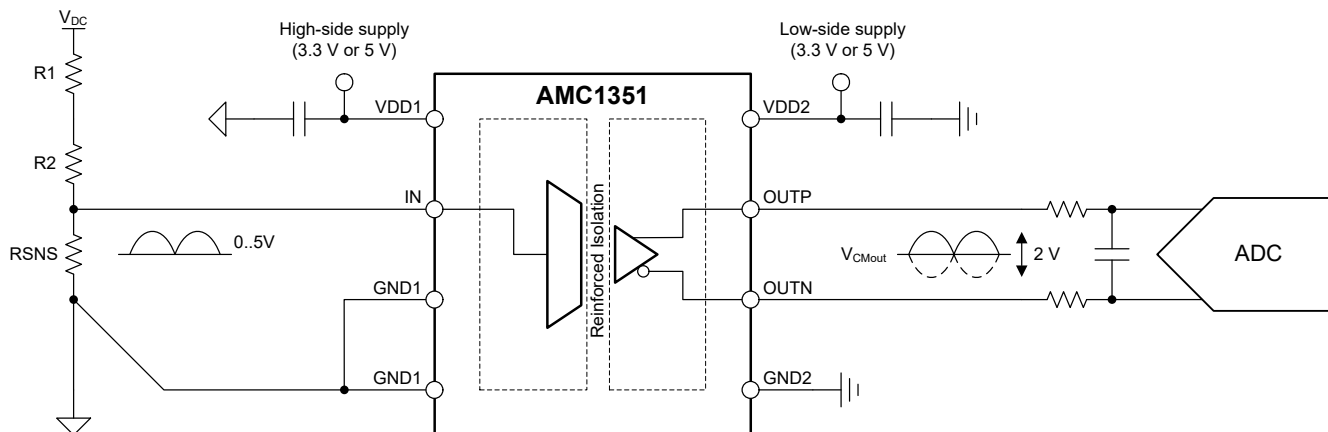
## 具有 5V 输入电压的 AMC1351 精密增强型隔离放大器

### 1 特性

- 线性输入电压范围：-0.25 V 至 5 V
- 高输入阻抗：1.25m $\Omega$  (典型值)
- 固定增益：0.4 V/V
- 低直流误差：
  - 失调电压误差  $\pm 1.5\text{mV}$  (最大值)
  - 温漂： $\pm 15\mu\text{V}/^\circ\text{C}$  (最大值)
  - 增益误差： $\pm 0.2\%$  (最大值)
  - 增益漂移： $\pm 35\text{ppm}/^\circ\text{C}$  (最大值)
  - 非线性  $\pm 0.02\%$  (最大值)
- 高侧和低侧运行电压：3.3V 或 5V
- 高 CMTI：100kV/ $\mu\text{s}$  (最小值)
- 失效防护输出
- 安全相关认证：
  - 7070- $V_{\text{PK}}$  增强型隔离，符合 DIN VDE V 0884-11：2017-01
  - 符合 UL1577 标准且长达 1 分钟的 5000V $_{\text{RMS}}$  隔离
- 可在工业级工作温度范围内正常工作：-40 $^\circ\text{C}$  至 +125 $^\circ\text{C}$

### 2 应用

- 可用于以下应用的隔离式直流电压检测：
  - 电机驱动器
  - 变频器
  - 光伏逆变器
  - 电源



典型应用

### 3 说明

AMC1351 是一款隔离式精密放大器，此放大器的输出与输入电路由抗电磁干扰性能极强的隔离栅隔开。该隔离栅经认证可提供高达 5kV $_{\text{RMS}}$  的增强型电隔离，符合 VDE V 0884-11 和 UL1577 标准，并且可支持最高 1.5kV $_{\text{RMS}}$  的工作电压。

该隔离栅可将系统中以不同共模电压电平运行的各器件隔开，并保护低压侧免受可能有损的电压冲击。

AMC1351 的高阻抗输入针对与高阻抗电阻分压器或具有高输出电阻的其他电压信号源的连接进行了优化。具有出色的精度和低温漂，可支持在 -40 $^\circ\text{C}$  至 +125 $^\circ\text{C}$  的工业级工作温度范围内，在直流/直流转换器、变频器、电机驱动或其他应用中进行精确的直流电压检测。

#### 器件信息(1)

| 器件型号    | 封装       | 封装尺寸 (标称值)             |
|---------|----------|------------------------|
| AMC1351 | SOIC (8) | 5.85mm $\times$ 7.50mm |

(1) 如需了解所有可用封装，请参阅数据表末尾的可订购产品附录。



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## 4 Revision History

注：以前版本的页码可能与当前版本的页码不同

| DATE          | REVISION | NOTES           |
|---------------|----------|-----------------|
| December 2021 | *        | Initial Release |

## 5 Pin Configuration and Functions

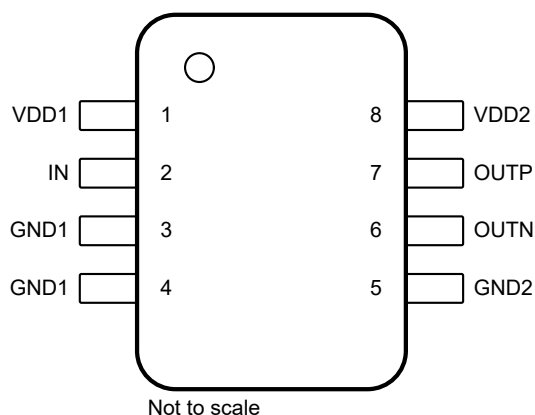


图 5-1. DWV Package, 8-Pin SOIC (Top View)

表 5-1. Pin Functions

| PIN |      | TYPE             | DESCRIPTION                                                                                        |
|-----|------|------------------|----------------------------------------------------------------------------------------------------|
| NO. | NAME |                  |                                                                                                    |
| 1   | VDD1 | High-side power  | High-side power supply <sup>(1)</sup>                                                              |
| 2   | IN   | Analog input     | Analog input                                                                                       |
| 3   | GND1 | High-side ground | High-side analog ground reference for input amplifier. Connect to pin 4. Do not leave unconnected. |
| 4   | GND1 | High-side ground | High-side analog ground                                                                            |
| 5   | GND2 | Low-side ground  | Low-side analog ground                                                                             |
| 6   | OUTN | Analog output    | Inverting analog output                                                                            |
| 7   | OUTP | Analog output    | Noninverting analog output                                                                         |
| 8   | VDD2 | Low-side power   | Low-side power supply <sup>(1)</sup>                                                               |

(1) See the [Power Supply Recommendations](#) section for power-supply decoupling recommendations.

## 6 Specifications

### 6.1 Absolute Maximum Ratings

see<sup>(1)</sup>

|                       |                                              | MIN        | MAX        | UNIT |
|-----------------------|----------------------------------------------|------------|------------|------|
| Power-supply voltage  | High-side VDD1 to GND1                       | – 0.3      | 6.5        | V    |
|                       | Low-side VDD2 to GND2                        | – 0.3      | 6.5        |      |
| Analog input voltage  | IN                                           | – 1        | 15         | V    |
| Analog output voltage | OUTP, OUTN                                   | GND2 – 0.5 | VDD2 + 0.5 | V    |
| Input current         | Continuous, any pin except power-supply pins | – 10       | 10         | mA   |
| Temperature           | Junction, T <sub>J</sub>                     |            | 150        | °C   |
|                       | Storage, T <sub>stg</sub>                    | – 65       | 150        |      |

- (1) Operation outside the *Absolute Maximum Ratings* may cause permanent device damage. *Absolute Maximum Ratings* do not imply functional operation of the device at these or any other conditions beyond those listed under *Recommended Operating Conditions*. If used outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime

### 6.2 ESD Ratings

|                    |                         |                                                                           | VALUE | UNIT |
|--------------------|-------------------------|---------------------------------------------------------------------------|-------|------|
| V <sub>(ESD)</sub> | Electrostatic discharge | Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>         | ±2000 | V    |
|                    |                         | Charged-device model (CDM), per per ANSI/ESDA/JEDEC JS-002 <sup>(2)</sup> | ±1000 |      |

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.  
 (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 6.3 Recommended Operating Conditions

over operating ambient temperature range (unless otherwise noted)

|                          |                                      |                         |  | MIN    | NOM  | MAX | UNIT |
|--------------------------|--------------------------------------|-------------------------|--|--------|------|-----|------|
| <b>POWER SUPPLY</b>      |                                      |                         |  |        |      |     |      |
| VDD1                     | High-side power-supply               | VDD1 to GND1            |  | 3      | 5    | 5.5 | V    |
| VDD2                     | Low-side power-supply                | VDD2 to GND2            |  | 3      | 3.3  | 5.5 | V    |
| <b>ANALOG INPUT</b>      |                                      |                         |  |        |      |     |      |
| V <sub>Clipping</sub>    | Input voltage before clipping output |                         |  |        | 6.25 |     | V    |
| V <sub>FSR</sub>         | Specified linear full-scale voltage  |                         |  | – 0.25 |      | 5   | V    |
| <b>ANALOG OUTPUT</b>     |                                      |                         |  |        |      |     |      |
| C <sub>LOAD</sub>        | Capacitive load                      | On OUTP or OUTN to GND2 |  |        |      | 500 | pF   |
|                          |                                      | OUTP to OUTN            |  |        |      | 250 |      |
| R <sub>LOAD</sub>        | Resistive load                       | On OUTP or OUTN to GND2 |  |        | 10   | 1   | kΩ   |
| <b>TEMPERATURE RANGE</b> |                                      |                         |  |        |      |     |      |
| T <sub>A</sub>           | Operating ambient temperature        |                         |  | – 55   |      | 125 | °C   |
|                          | Specified ambient temperature        |                         |  | – 40   |      | 125 |      |

## 6.4 Thermal Information

| THERMAL METRIC <sup>(1)</sup> |                                              | AMC1351    | UNIT |
|-------------------------------|----------------------------------------------|------------|------|
|                               |                                              | DWV (SOIC) |      |
|                               |                                              | 8 PINS     |      |
| $R_{\theta JA}$               | Junction-to-ambient thermal resistance       | 84.6       | °C/W |
| $R_{\theta JC(top)}$          | Junction-to-case (top) thermal resistance    | 28.3       | °C/W |
| $R_{\theta JB}$               | Junction-to-board thermal resistance         | 41.1       | °C/W |
| $\psi_{JT}$                   | Junction-to-top characterization parameter   | 4.9        | °C/W |
| $\psi_{JB}$                   | Junction-to-board characterization parameter | 39.1       | °C/W |
| $R_{\theta JC(bot)}$          | Junction-to-case (bottom) thermal resistance | n/a        | °C/W |

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

## 6.5 Power Ratings

| PARAMETER |                                        | TEST CONDITIONS     | VALUE | UNIT |
|-----------|----------------------------------------|---------------------|-------|------|
| $P_D$     | Maximum power dissipation (both sides) | VDD1 = VDD2 = 5.5 V | 96    | mW   |
| $P_{D1}$  | Maximum power dissipation (high-side)  | VDD1 = 3.6 V        | 29    | mW   |
|           |                                        | VDD1 = 5.5 V        | 51    |      |
| $P_{D2}$  | Maximum power dissipation (low-side)   | VDD2 = 3.6 V        | 26    | mW   |
|           |                                        | VDD2 = 5.5 V        | 45    |      |

## 6.6 Insulation Specifications

over operating ambient temperature range (unless otherwise noted)

| PARAMETER                                  |                                                       | TEST CONDITIONS                                                                                                                                                                                                      | VALUE              | UNIT             |
|--------------------------------------------|-------------------------------------------------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|--------------------|------------------|
| GENERAL                                    |                                                       |                                                                                                                                                                                                                      |                    |                  |
| CLR                                        | External clearance <sup>(1)</sup>                     | Shortest pin-to-pin distance through air                                                                                                                                                                             | ≥ 8.5              | mm               |
| CPG                                        | External creepage <sup>(1)</sup>                      | Shortest pin-to-pin distance across the package surface                                                                                                                                                              | ≥ 8.5              | mm               |
| DTI                                        | Distance through insulation                           | Minimum internal gap (internal clearance) of the double insulation                                                                                                                                                   | ≥ 0.021            | mm               |
| CTI                                        | Comparative tracking index                            | DIN EN 60112 (VDE 0303-11); IEC 60112                                                                                                                                                                                | ≥ 600              | V                |
|                                            | Material group                                        | According to IEC 60664-1                                                                                                                                                                                             | I                  |                  |
|                                            | Overvoltage category per IEC 60664-1                  | Rated mains voltage ≤ 600 V <sub>RMS</sub>                                                                                                                                                                           | I-IV               |                  |
|                                            |                                                       | Rated mains voltage ≤ 1000 V <sub>RMS</sub>                                                                                                                                                                          | I-III              |                  |
| DIN VDE V 0884-11 (VDE V 0884-11): 2017-01 |                                                       |                                                                                                                                                                                                                      |                    |                  |
| V <sub>IORM</sub>                          | Maximum repetitive peak isolation voltage             | At AC voltage                                                                                                                                                                                                        | 2120               | V <sub>PK</sub>  |
| V <sub>IOWM</sub>                          | Maximum-rated isolation working voltage               | At AC voltage (sine wave)                                                                                                                                                                                            | 1500               | V <sub>RMS</sub> |
|                                            |                                                       | At DC voltage                                                                                                                                                                                                        | 2120               | V <sub>DC</sub>  |
| V <sub>IOTM</sub>                          | Maximum transient isolation voltage                   | V <sub>TEST</sub> = V <sub>IOTM</sub> , t = 60 s (qualification test)                                                                                                                                                | 7070               | V <sub>PK</sub>  |
|                                            |                                                       | V <sub>TEST</sub> = 1.2 × V <sub>IOTM</sub> , t = 1 s (100% production test)                                                                                                                                         | 8480               |                  |
| V <sub>IOSM</sub>                          | Maximum surge isolation voltage <sup>(2)</sup>        | Test method per IEC 60065, 1.2/50-μs waveform, V <sub>TEST</sub> = 1.6 × V <sub>IOSM</sub> = 12800 V <sub>PK</sub> (qualification)                                                                                   | 8000               | V <sub>PK</sub>  |
| q <sub>pd</sub>                            | Apparent charge <sup>(3)</sup>                        | Method a, after input/output safety test subgroups 2 and 3, V <sub>ini</sub> = V <sub>IOTM</sub> , t <sub>ini</sub> = 60 s, V <sub>pd(m)</sub> = 1.2 × V <sub>IORM</sub> , t <sub>m</sub> = 10 s                     | ≤ 5                | pC               |
|                                            |                                                       | Method a, after environmental tests subgroup 1, V <sub>ini</sub> = V <sub>IOTM</sub> , t <sub>ini</sub> = 60 s, V <sub>pd(m)</sub> = 1.6 × V <sub>IORM</sub> , t <sub>m</sub> = 10 s                                 | ≤ 5                |                  |
|                                            |                                                       | Method b1, at routine test (100% production) and preconditioning (type test), V <sub>ini</sub> = V <sub>IOTM</sub> , t <sub>ini</sub> = 1 s, V <sub>pd(m)</sub> = 1.875 × V <sub>IORM</sub> , t <sub>m</sub> = 1 s   | ≤ 5                |                  |
| C <sub>IO</sub>                            | Barrier capacitance, input to output <sup>(4)</sup>   | V <sub>IO</sub> = 0.5 V <sub>PP</sub> at 1 MHz                                                                                                                                                                       | ~1.5               | pF               |
| R <sub>IO</sub>                            | Insulation resistance, input to output <sup>(4)</sup> | V <sub>IO</sub> = 500 V at T <sub>A</sub> = 25°C                                                                                                                                                                     | > 10 <sup>12</sup> | Ω                |
|                                            |                                                       | V <sub>IO</sub> = 500 V at 100°C ≤ T <sub>A</sub> ≤ 125°C                                                                                                                                                            | > 10 <sup>11</sup> |                  |
|                                            |                                                       | V <sub>IO</sub> = 500 V at T <sub>S</sub> = 150°C                                                                                                                                                                    | > 10 <sup>9</sup>  |                  |
|                                            | Pollution degree                                      |                                                                                                                                                                                                                      | 2                  |                  |
|                                            | Climatic category                                     |                                                                                                                                                                                                                      | 55/125/21          |                  |
| UL1577                                     |                                                       |                                                                                                                                                                                                                      |                    |                  |
| V <sub>ISO</sub>                           | Withstand isolation voltage                           | V <sub>TEST</sub> = V <sub>ISO</sub> = 5000 V <sub>RMS</sub> or 7071 V <sub>DC</sub> , t = 60 s (qualification), V <sub>TEST</sub> = 1.2 × V <sub>ISO</sub> = 6000 V <sub>RMS</sub> , t = 1 s (100% production test) | 5000               | V <sub>RMS</sub> |

- (1) Apply creepage and clearance requirements according to the specific equipment isolation standards of an application. Care must be taken to maintain the creepage and clearance distance of a board design to ensure that the mounting pads of the isolator on the printed circuit board (PCB) do not reduce this distance. Creepage and clearance on a PCB become equal in certain cases. Techniques such as inserting grooves, ribs, or both on a PCB are used to help increase these specifications.
- (2) Testing is carried out in air or oil to determine the intrinsic surge immunity of the isolation barrier.
- (3) Apparent charge is electrical discharge caused by a partial discharge (pd).
- (4) All pins on each side of the barrier are tied together, creating a two-pin device.

## 6.7 Safety-Related Certifications

| VDE                                                                                                                                                      | UL                                          |
|----------------------------------------------------------------------------------------------------------------------------------------------------------|---------------------------------------------|
| Certified according to DIN VDE V 0884-11 (VDE V 0884-11): 2017-01,<br>DIN EN 60950-1 (VDE 0805 Teil 1): 2014-08, and<br>DIN EN 60065 (VDE 0860): 2005-11 | Recognized under 1577 component recognition |
| Reinforced insulation                                                                                                                                    | Single protection                           |
| Certificate number: pending                                                                                                                              | File number: E181974                        |

## 6.8 Safety Limiting Values

Safety limiting<sup>(1)</sup> intends to minimize potential damage to the isolation barrier upon failure of input or output circuitry. A failure of the I/O can allow low resistance to ground or the supply and, without current limiting, dissipate sufficient power to over-heat the die and damage the isolation barrier potentially leading to secondary system failures.

| PARAMETER      |                                         | TEST CONDITIONS                                                                             | MIN | TYP | MAX  | UNIT |
|----------------|-----------------------------------------|---------------------------------------------------------------------------------------------|-----|-----|------|------|
| I <sub>S</sub> | Safety input, output, or supply current | R <sub>θJA</sub> = 84.6°C/W, VDDx = 5.5 V,<br>T <sub>J</sub> = 150°C, T <sub>A</sub> = 25°C |     |     | 270  | mA   |
|                |                                         | R <sub>θJA</sub> = 84.6°C/W, VDDx = 3.6 V,<br>T <sub>J</sub> = 150°C, T <sub>A</sub> = 25°C |     |     | 410  |      |
| P <sub>S</sub> | Safety input, output, or total power    | R <sub>θJA</sub> = 84.6°C/W, T <sub>J</sub> = 150°C, T <sub>A</sub> = 25°C                  |     |     | 1480 | mW   |
| T <sub>S</sub> | Maximum safety temperature              |                                                                                             |     |     | 150  | °C   |

- (1) The maximum safety temperature, T<sub>S</sub>, has the same value as the maximum junction temperature, T<sub>J</sub>, specified for the device. The I<sub>S</sub> and P<sub>S</sub> parameters represent the safety current and safety power, respectively. Do not exceed the maximum limits of I<sub>S</sub> and P<sub>S</sub>. These limits vary with the ambient temperature, T<sub>A</sub>.

The junction-to-air thermal resistance, R<sub>θJA</sub>, in the [Thermal Information](#) table is that of a device installed on a high-K test board for leaded surface-mount packages. Use these equations to calculate the value for each parameter:

T<sub>J</sub> = T<sub>A</sub> + R<sub>θJA</sub> × P, where P is the power dissipated in the device.

T<sub>J(max)</sub> = T<sub>S</sub> = T<sub>A</sub> + R<sub>θJA</sub> × P<sub>S</sub>, where T<sub>J(max)</sub> is the maximum junction temperature.

P<sub>S</sub> = I<sub>S</sub> × VDD<sub>max</sub>, where VDD<sub>max</sub> is the maximum supply voltage for high-side and low-side.

## 6.9 Electrical Characteristics

minimum and maximum specifications apply from  $T_A = -40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$ ,  $V_{DD1} = 3.0\text{ V}$  to  $5.5\text{ V}$ ,  $V_{DD2} = 3.0\text{ V}$  to  $5.5\text{ V}$ ,  $I_N = -0.25\text{ V}$  to  $+5\text{ V}$  (unless otherwise noted); typical specifications are at  $T_A = 25^{\circ}\text{C}$ ,  $V_{DD1} = 5\text{ V}$ , and  $V_{DD2} = 3.3\text{ V}$

| PARAMETER                |                                                  | TEST CONDITIONS                                                                                                                 | MIN     | TYP              | MAX   | UNIT                           |
|--------------------------|--------------------------------------------------|---------------------------------------------------------------------------------------------------------------------------------|---------|------------------|-------|--------------------------------|
| <b>ANALOG INPUT</b>      |                                                  |                                                                                                                                 |         |                  |       |                                |
| $V_{OS}$                 | Offset voltage <sup>(2)</sup>                    | $T_A = 25^{\circ}\text{C}$ , $I_N = \text{GND1}$ ,<br>$4.5\text{ V} \leq V_{DD1} \leq 5.5\text{ V}$ <sup>(1)</sup>              | - 1.5   | $\pm 0.3$        | 1.5   | mV                             |
|                          |                                                  | $T_A = 25^{\circ}\text{C}$ , $I_N = \text{GND1}$ ,<br>$3.0\text{ V} \leq V_{DD1} \leq 5.5\text{ V}$ <sup>(3)</sup>              | - 2.5   | - 0.8            | 2.5   |                                |
| $\Delta V_{OS}$          | Offset voltage long-term stability               | 10 years at $T_A = 55^{\circ}\text{C}$                                                                                          |         | 0 <sup>(7)</sup> |       | mV                             |
| $\text{TCV}_{OS}$        | Offset voltage thermal drift <sup>(5)</sup>      | $I_N = \text{GND1}$                                                                                                             | - 15    | $\pm 3$          | 15    | $\mu\text{V}/^{\circ}\text{C}$ |
| $\Delta \text{TCV}_{OS}$ | Offset voltage thermal drift long-term stability | 10 years at $T_A = 55^{\circ}\text{C}$ ,<br>$I_N = \text{GND1}$                                                                 |         | 0 <sup>(7)</sup> |       | $\text{mV}/^{\circ}\text{C}$   |
| $R_{IN}$                 | Input resistance                                 |                                                                                                                                 | 1       | 1.25             | 1.5   | $\text{M}\Omega$               |
| $\Delta R_{IN}$          | Input resistance long-term stability             | 10 years at $T_A = 55^{\circ}\text{C}$                                                                                          |         | 0 <sup>(7)</sup> |       | ppm                            |
| $\text{TCR}_{IN}$        | Input resistance thermal drift                   | $-40^{\circ}\text{C} \leq T_A \leq 85^{\circ}\text{C}$                                                                          |         | 5                |       | $\text{ppm}/^{\circ}\text{C}$  |
| $C_{IN}$                 | Input capacitance                                | $f_{IN} = 275\text{ kHz}$                                                                                                       |         | 4                |       | pF                             |
| <b>ANALOG OUTPUT</b>     |                                                  |                                                                                                                                 |         |                  |       |                                |
|                          | Nominal gain                                     |                                                                                                                                 |         | 0.40             |       | V/V                            |
| $E_G$                    | Gain error <sup>(1)</sup>                        | $T_A = 25^{\circ}\text{C}$                                                                                                      | - 0.2%  | $\pm 0.05\%$     | 0.2%  |                                |
| $\Delta E_G$             | Gain error long-term stability                   | 10 years at $T_A = 55^{\circ}\text{C}$                                                                                          |         | 0 <sup>(7)</sup> |       |                                |
| $\text{TCE}_G$           | Gain error thermal drift <sup>(1) (6)</sup>      |                                                                                                                                 | - 35    | $\pm 10$         | 35    | $\text{ppm}/^{\circ}\text{C}$  |
| $\Delta \text{TCE}_G$    | Gain error thermal drift long-term stability     | 10 years at $T_A = 55^{\circ}\text{C}$                                                                                          |         | 0 <sup>(7)</sup> |       | $\text{ppm}/^{\circ}\text{C}$  |
|                          | Nonlinearity <sup>(1)</sup>                      |                                                                                                                                 | - 0.02% | $\pm 0.003\%$    | 0.02% |                                |
|                          | Nonlinearity thermal drift                       |                                                                                                                                 |         | 0.2              |       | $\text{ppm}/^{\circ}\text{C}$  |
| THD                      | Total harmonic distortion <sup>(4)</sup>         | $V_{IN} = 5\text{ V}_{PP}$ , $f_{IN} = 10\text{ kHz}$ ,<br>$\text{BW} = 100\text{ kHz}$                                         |         | - 82             |       | dB                             |
| SNR                      | Signal-to-noise ratio                            | $V_{IN} = 5\text{ V}_{PP}$ , $f_{IN} = 1\text{ kHz}$ ,<br>$\text{BW} = 10\text{ kHz}$                                           | 75      | 79               |       | dB                             |
|                          |                                                  | $V_{IN} = 5\text{ V}_{PP}$ , $f_{IN} = 10\text{ kHz}$ ,<br>$\text{BW} = 100\text{ kHz}$                                         |         | 69               |       |                                |
|                          | Output noise                                     | $I_N = \text{GND1}$ , $\text{BW} = 100\text{ kHz}$                                                                              |         | 250              |       | $\mu\text{V}_{rms}$            |
| PSRR                     | Power-supply rejection ratio <sup>(2)</sup>      | PSRR vs $V_{DD1}$ , DC                                                                                                          |         | - 67             |       | dB                             |
|                          |                                                  | PSRR vs $V_{DD2}$ , DC                                                                                                          |         | - 80             |       |                                |
|                          |                                                  | PSRR vs $V_{DD1}$ with 10-kHz,<br>100-mV ripple                                                                                 |         | - 65             |       |                                |
|                          |                                                  | PSRR vs $V_{DD2}$ with 10-kHz,<br>100-mV ripple                                                                                 |         | - 64             |       |                                |
| $V_{CMout}$              | Output common-mode voltage                       |                                                                                                                                 | 1.39    | 1.44             | 1.49  | V                              |
| $V_{CLIPout}$            | Clipping differential output voltage             | $V_{OUT} = (V_{OUTP} - V_{OUTN})$ ,<br>$V_{IN} > V_{Clipping}$                                                                  |         | 2.49             |       | V                              |
| $V_{Fail-safe}$          | Fail-safe differential output voltage            | $V_{DD1}$ undervoltage or $V_{DD1}$ missing                                                                                     | - 2.57  | - 2.5            |       | V                              |
| BW                       | Output bandwidth                                 |                                                                                                                                 | 275     | 300              |       | kHz                            |
| $R_{OUT}$                | Output resistance                                | On $\text{OUTP}$ or $\text{OUTN}$                                                                                               |         | < 0.2            |       | $\Omega$                       |
|                          | Output short-circuit current                     | On $\text{OUTP}$ or $\text{OUTN}$ , sourcing or sinking,<br>$I_N = \text{GND1}$ , outputs shorted to<br>either GND or $V_{DD2}$ |         | 14               |       | mA                             |
| CMTI                     | Common-mode transient immunity                   |                                                                                                                                 | 100     | 150              |       | $\text{kV}/\mu\text{s}$        |
| <b>POWER SUPPLY</b>      |                                                  |                                                                                                                                 |         |                  |       |                                |

## 6.9 Electrical Characteristics (continued)

minimum and maximum specifications apply from  $T_A = -40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$ ,  $V_{DD1} = 3.0\text{ V}$  to  $5.5\text{ V}$ ,  $V_{DD2} = 3.0\text{ V}$  to  $5.5\text{ V}$ ,  $I_{IN} = -0.25\text{ V}$  to  $+5\text{ V}$  (unless otherwise noted); typical specifications are at  $T_A = 25^{\circ}\text{C}$ ,  $V_{DD1} = 5\text{ V}$ , and  $V_{DD2} = 3.3\text{ V}$

| PARAMETER      |                                       | TEST CONDITIONS                         | MIN  | TYP  | MAX  | UNIT |
|----------------|---------------------------------------|-----------------------------------------|------|------|------|------|
| $V_{DD1_{UV}}$ | VDD1 undervoltage detection threshold | VDD1 rising                             | 2.5  | 2.7  | 2.9  | V    |
|                |                                       | VDD1 falling                            | 2.4  | 2.6  | 2.8  |      |
| $V_{DD2_{UV}}$ | VDD2 undervoltage detection threshold | VDD2 rising                             | 2.2  | 2.45 | 2.65 | V    |
|                |                                       | VDD2 falling                            | 1.85 | 2.0  | 2.2  |      |
| $I_{DD1}$      | High-side supply current              | $3.0\text{ V} < V_{DD1} < 3.6\text{ V}$ |      | 6.0  | 8.1  | mA   |
|                |                                       | $4.5\text{ V} < V_{DD1} < 5.5\text{ V}$ |      | 7.0  | 9.3  |      |
| $I_{DD2}$      | Low-side supply current               | $3.0\text{ V} < V_{DD2} < 3.6\text{ V}$ |      | 5.3  | 7.2  | mA   |
|                |                                       | $4.5\text{ V} < V_{DD2} < 5.5\text{ V}$ |      | 5.9  | 8.1  |      |

- (1) The typical value includes one standard deviation (*sigma*) at nominal operating conditions.
- (2) This parameter is input referred.
- (3) The typical value is at  $V_{DD1} = 3.3\text{ V}$ .
- (4) THD is the ratio of the rms sum of the amplitudes of first five higher harmonics to the amplitude of the fundamental.
- (5) Offset error temperature drift is calculated using the box method, as described by the following equation:  

$$TCV_{OS} = (V_{OS,MAX} - V_{OS,MIN}) / TempRange$$
where  $V_{OS,MAX}$  and  $V_{OS,MIN}$  refer to the maximum and minimum  $V_{OS}$  values measured within the temperature range ( $-40$  to  $125^{\circ}\text{C}$ ).
- (6) Gain error temperature drift is calculated using the box method, as described by the following equation:  

$$TCE_G (ppm) = ((E_{G,MAX} - E_{G,MIN}) / TempRange) \times 10^4$$
where  $E_{G,MAX}$  and  $E_{G,MIN}$  refer to the maximum and minimum  $E_G$  values (in %) measured within the temperature range ( $-40$  to  $125^{\circ}\text{C}$ ).
- (7) Value is below measurement capability.

## 6.10 Switching Characteristics

over operating ambient temperature range (unless otherwise noted)

| PARAMETER |                                     | TEST CONDITIONS                                                                              | MIN | TYP | MAX | UNIT          |
|-----------|-------------------------------------|----------------------------------------------------------------------------------------------|-----|-----|-----|---------------|
| $t_r$     | Output signal rise time             |                                                                                              |     | 1.3 |     | $\mu\text{s}$ |
| $t_f$     | Output signal fall time             |                                                                                              |     | 1.3 |     | $\mu\text{s}$ |
|           | IN to OUTx signal delay (50% – 10%) | Unfiltered output                                                                            |     | 1   | 1.5 | $\mu\text{s}$ |
|           | IN to OUTx signal delay (50% – 50%) | Unfiltered output                                                                            |     | 1.6 | 2.1 | $\mu\text{s}$ |
|           | IN to OUTx signal delay (50% – 90%) | Unfiltered output                                                                            |     | 2.5 | 3   | $\mu\text{s}$ |
| $t_{AS}$  | Analog settling time                | VDD1 step to 3.0 V with VDD2 $\geq$ 3.0 V, to $V_{OUTP}$ and $V_{OUTN}$ valid, 0.1% settling |     | 500 | 800 | $\mu\text{s}$ |

## 6.11 Timing Diagram

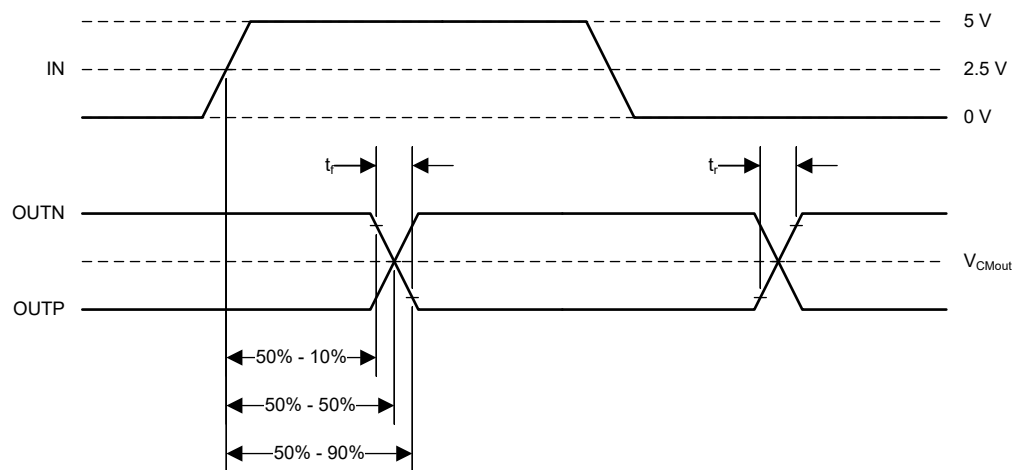


图 6-1. Rise, Fall, and Delay Time Definition

## 6.12 Insulation Characteristics Curves

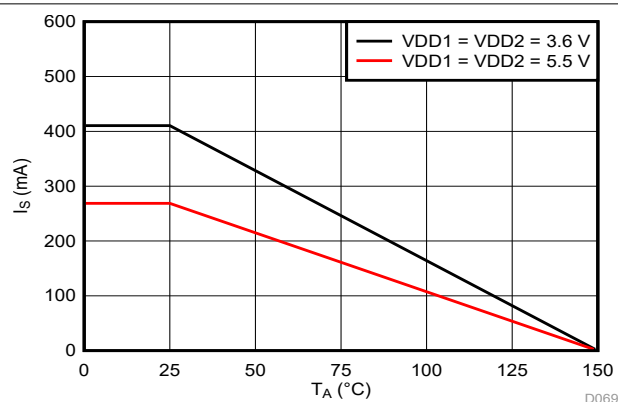


图 6-2. Thermal Derating Curve for Safety-Limiting Current per VDE

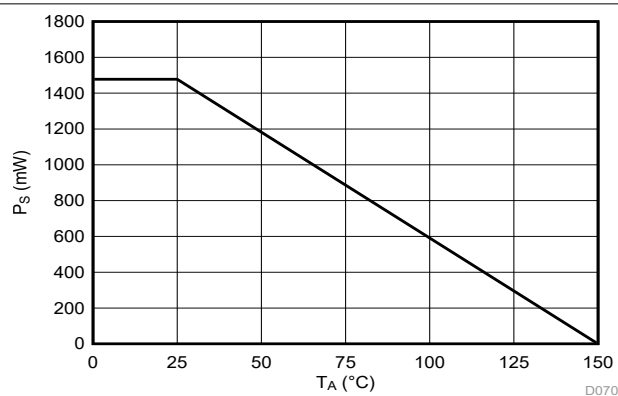
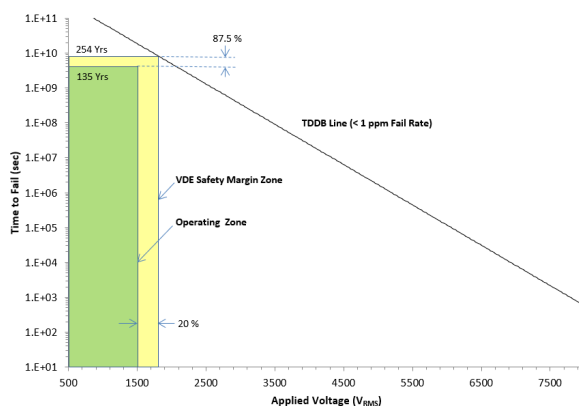


图 6-3. Thermal Derating Curve for Safety-Limiting Power per VDE



$T_A$  up to 150°C, stress-voltage frequency = 60 Hz, isolation working voltage = 1500  $V_{RMS}$ , operating lifetime = 135 years

图 6-4. Reinforced Isolation Capacitor Lifetime Projection

## 6.13 Typical Characteristics

at VDD1 = 5 V, VDD2 = 3.3 V, IN = 0 V to 5 V, and  $f_{IN} = 10$  kHz (unless otherwise noted)

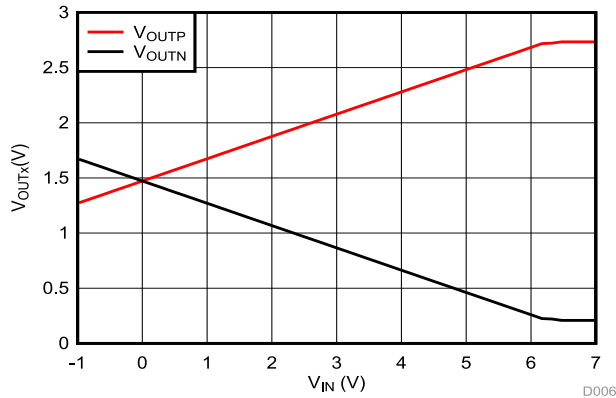
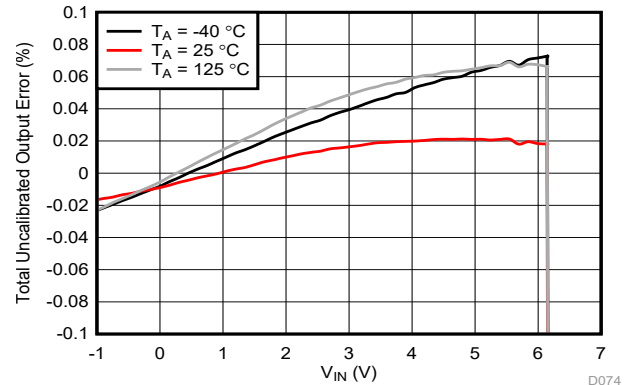


图 6-5. Output Voltage vs Input Voltage



Total uncalibrated output error is defined as:  
 $(V_{OUT} - V_{IN} \times G) / (V_{Clipping} \times G)$ , where  $G$  is the nominal gain of the device (0.4 V/V) and  $V_{Clipping}$  is 6.25 V

图 6-6. Total Uncalibrated Output Error vs Input Voltage

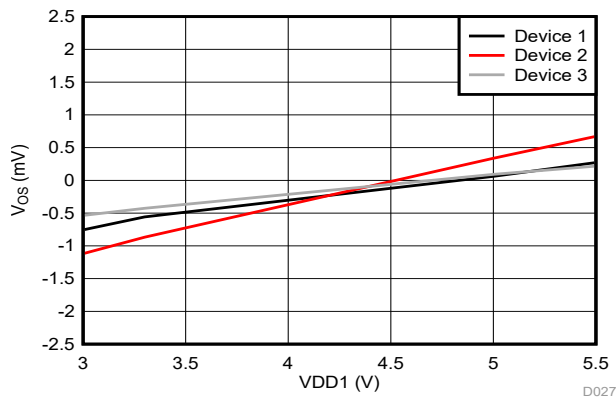


图 6-7. Input Offset Voltage vs High-Side Supply Voltage

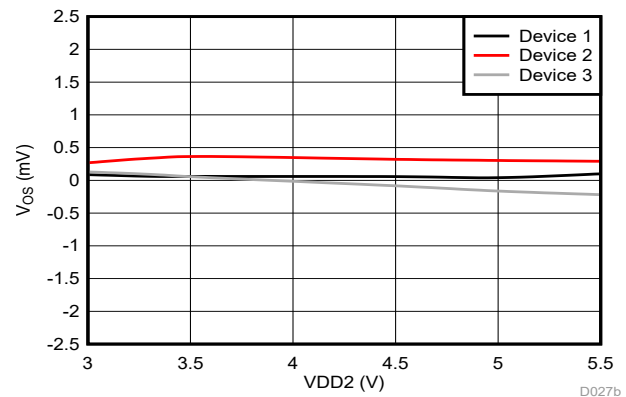


图 6-8. Input Offset Voltage vs Low-Side Supply Voltage

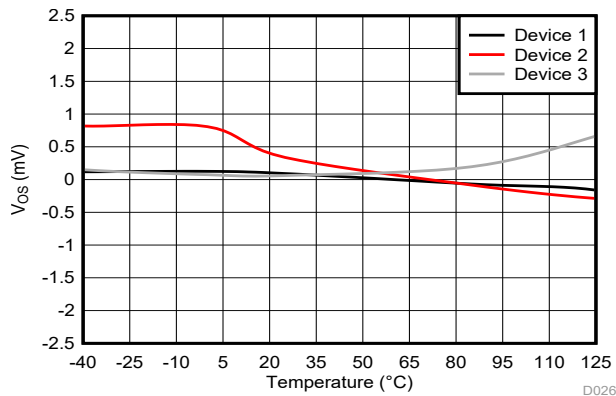


图 6-9. Input Offset Voltage vs Temperature

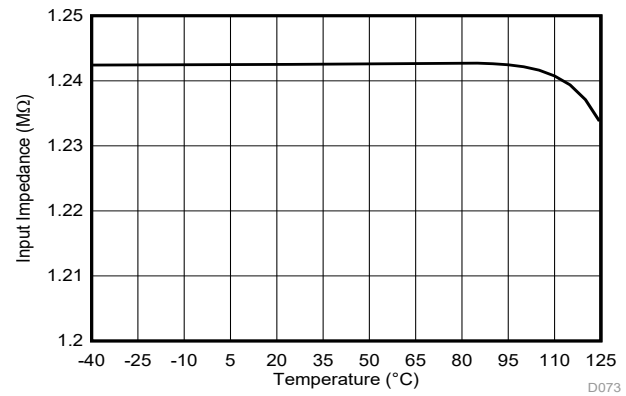


图 6-10. Input Impedance vs Temperature

## 6.13 Typical Characteristics (continued)

at VDD1 = 5 V, VDD2 = 3.3 V, IN = 0 V to 5 V, and  $f_{IN} = 10$  kHz (unless otherwise noted)

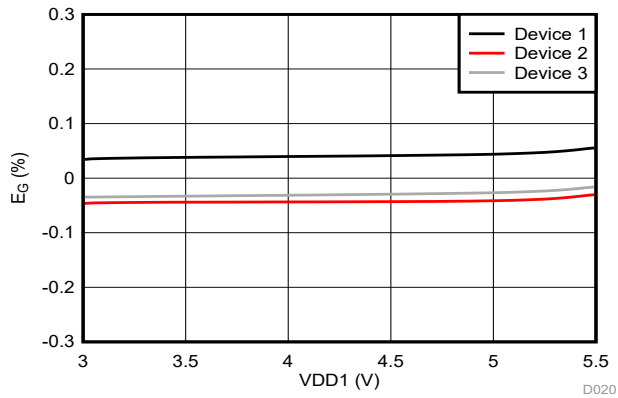


图 6-11. Gain Error vs High-Side Supply Voltage

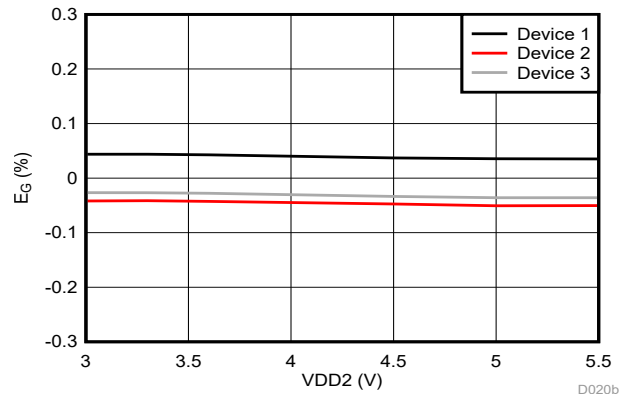


图 6-12. Gain Error vs Low-Side Supply Voltage

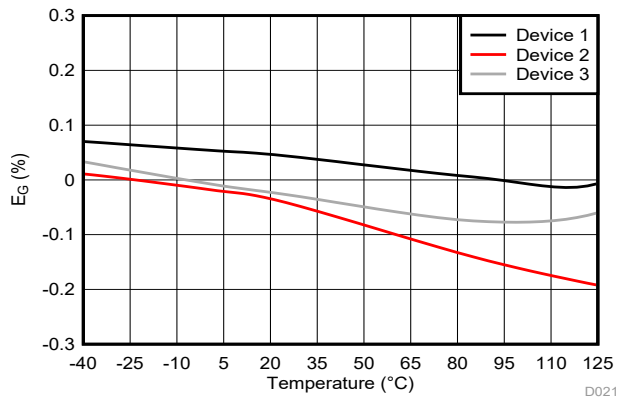


图 6-13. Gain Error vs Temperature

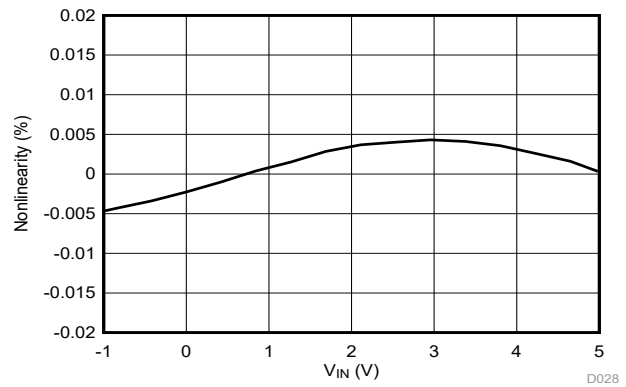


图 6-14. Nonlinearity vs Input Voltage

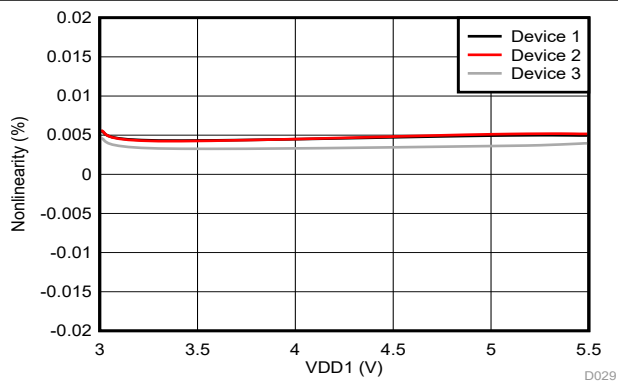


图 6-15. Nonlinearity vs High-Side Supply Voltage

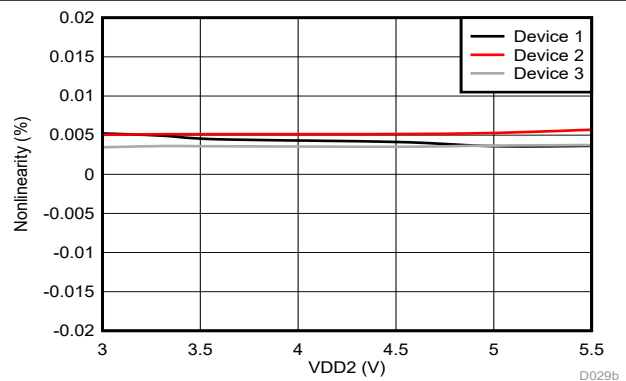


图 6-16. Nonlinearity vs Low-Side Supply Voltage

## 6.13 Typical Characteristics (continued)

at VDD1 = 5 V, VDD2 = 3.3 V, IN = 0 V to 5 V, and  $f_{IN} = 10$  kHz (unless otherwise noted)

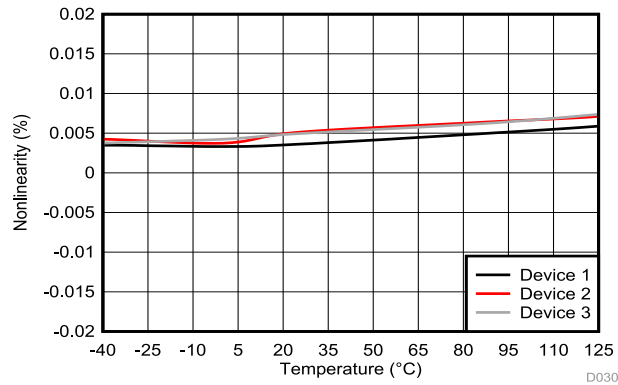


图 6-17. Nonlinearity vs Temperature

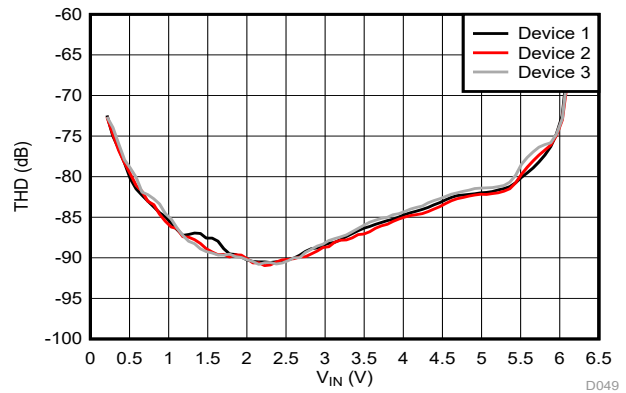


图 6-18. Total Harmonic Distortion vs Input Voltage

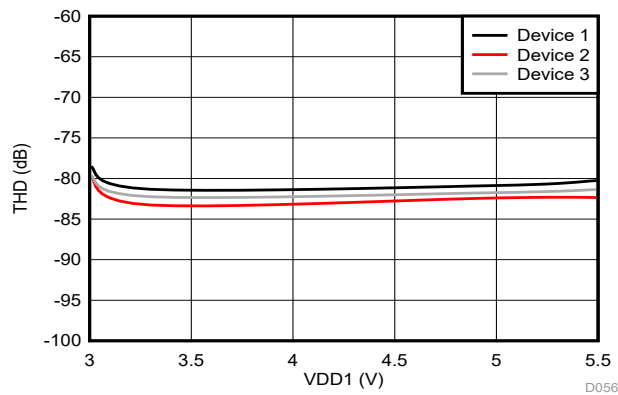


图 6-19. Total Harmonic Distortion vs High-Side Supply Voltage

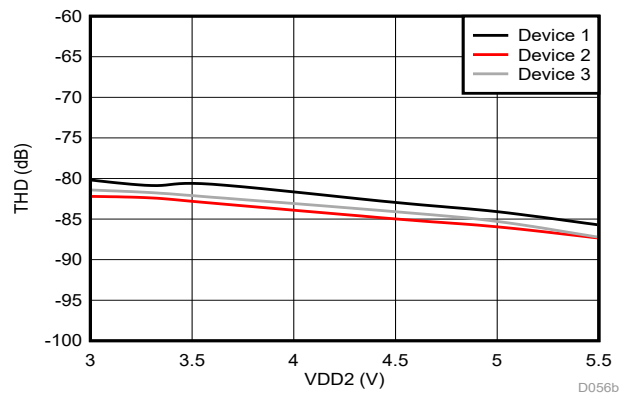


图 6-20. Total Harmonic Distortion vs Low-Side Supply Voltage

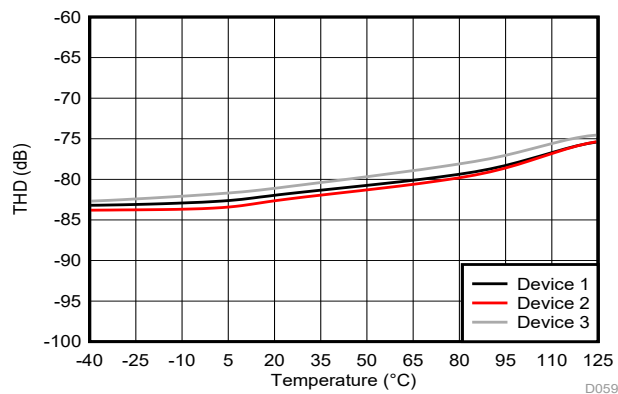


图 6-21. Total Harmonic Distortion vs Temperature

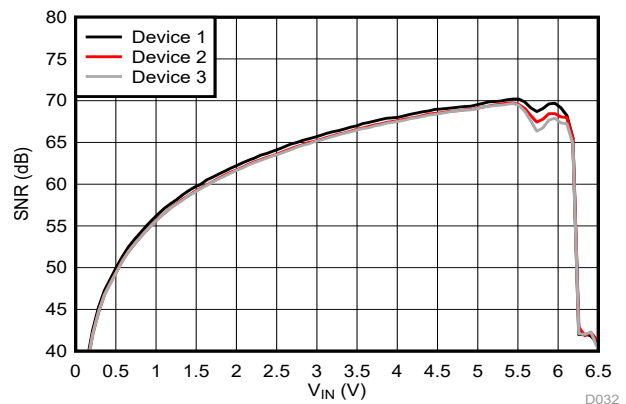


图 6-22. Signal-to-Noise Ratio vs Input Voltage

## 6.13 Typical Characteristics (continued)

at VDD1 = 5 V, VDD2 = 3.3 V, IN = 0 V to 5 V, and  $f_{IN} = 10$  kHz (unless otherwise noted)

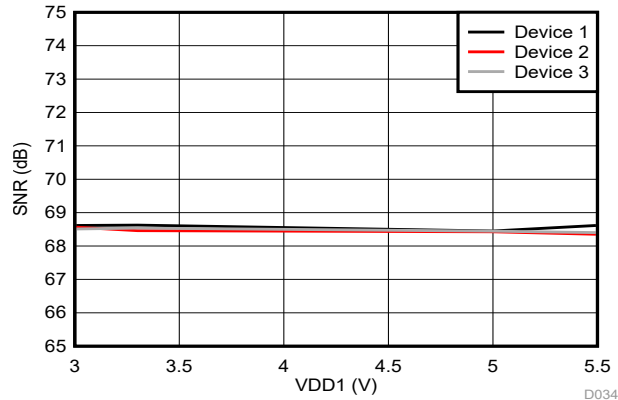


图 6-23. Signal-to-Noise Ratio vs High-Side Supply Voltage

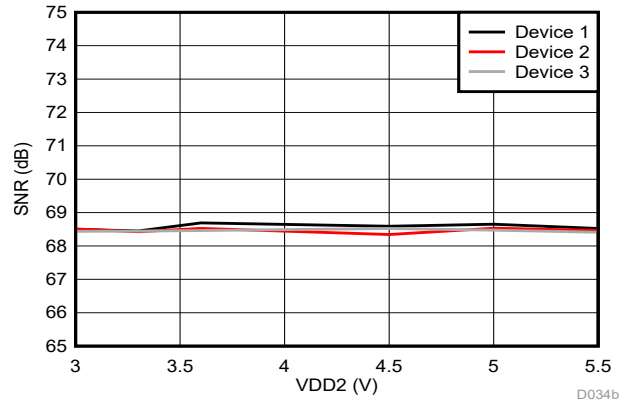


图 6-24. Signal-to-Noise Ratio vs Low-Side Supply Voltage

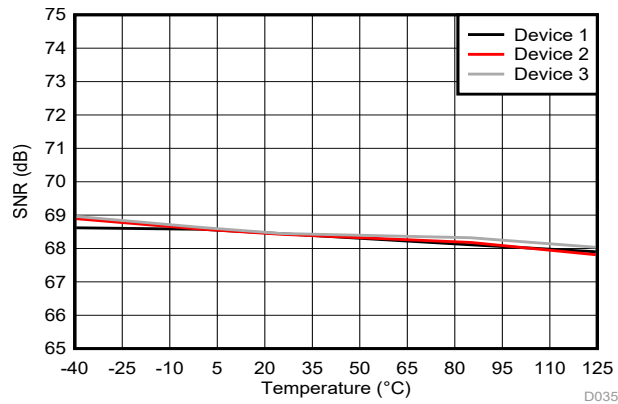


图 6-25. Signal-to-Noise Ratio vs Temperature

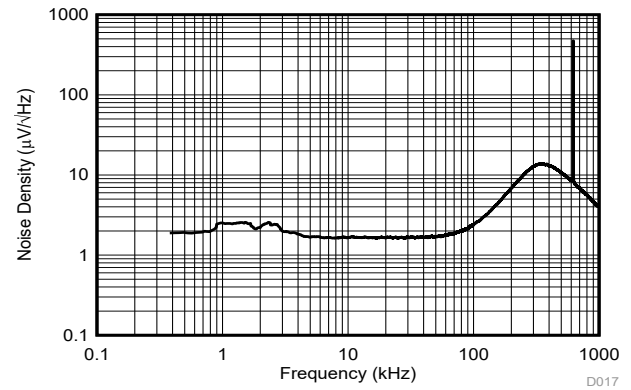


图 6-26. Input-Referred Noise Density vs Frequency

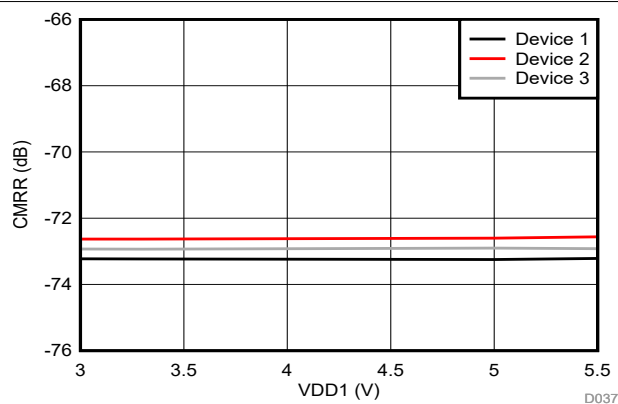


图 6-27. Common-Mode Rejection Ratio vs Supply Voltage

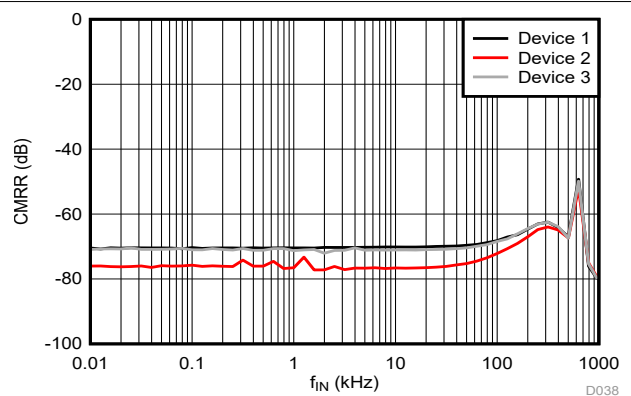


图 6-28. Common-Mode Rejection Ratio vs Input Frequency

## 6.13 Typical Characteristics (continued)

at VDD1 = 5 V, VDD2 = 3.3 V, IN = 0 V to 5 V, and  $f_{IN} = 10$  kHz (unless otherwise noted)

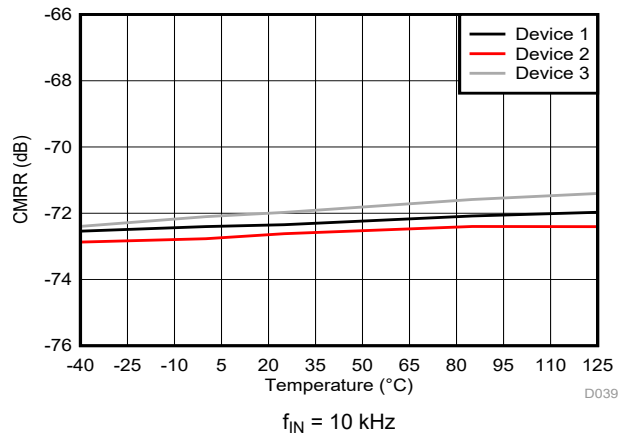


图 6-29. Common-Mode Rejection Ratio vs Temperature

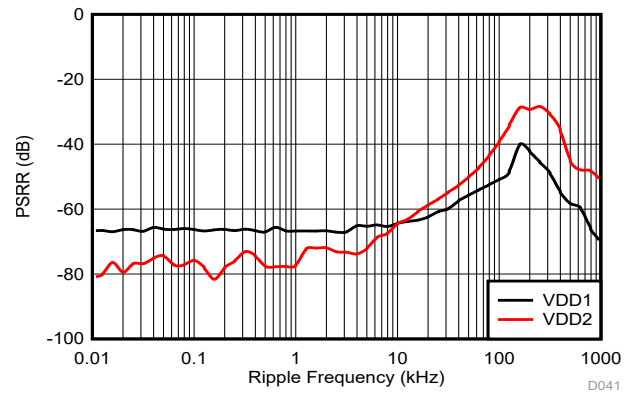


图 6-30. Power-Supply Rejection Ratio vs Ripple Frequency

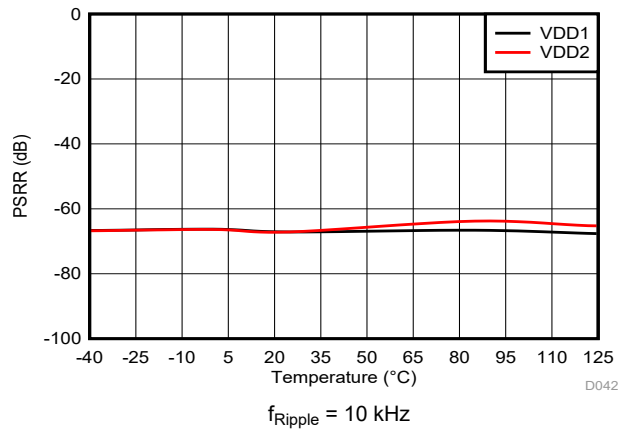


图 6-31. Power-Supply Rejection Ratio vs Temperature

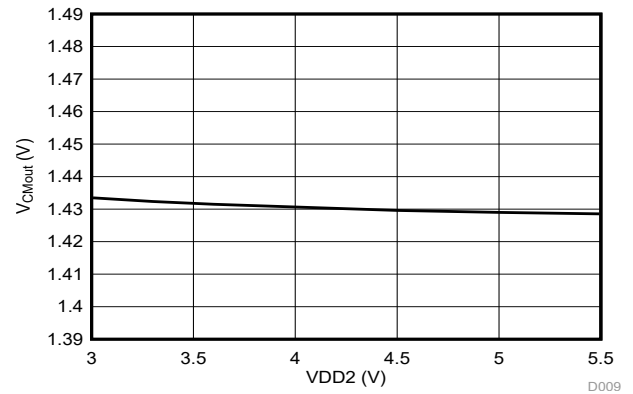


图 6-32. Common-Mode Output Voltage vs Supply Voltage

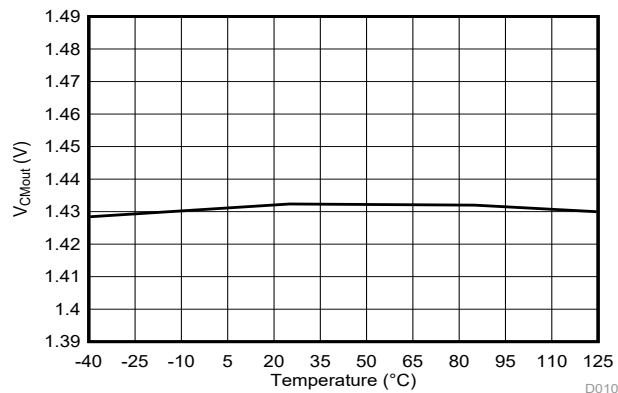


图 6-33. Common-Mode Output Voltage vs Temperature

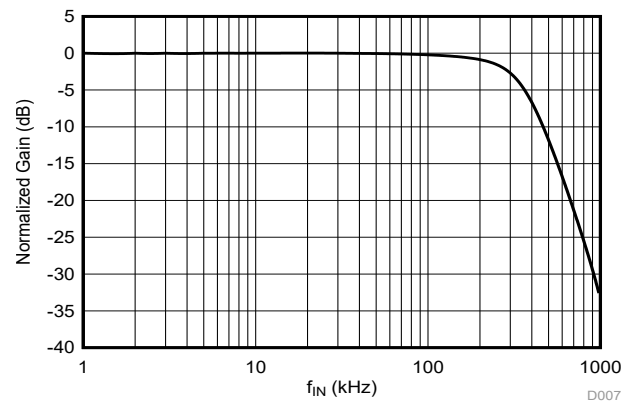


图 6-34. Normalized Gain vs Input Frequency

## 6.13 Typical Characteristics (continued)

at VDD1 = 5 V, VDD2 = 3.3 V, IN = 0 V to 5 V, and  $f_{IN}$  = 10 kHz (unless otherwise noted)

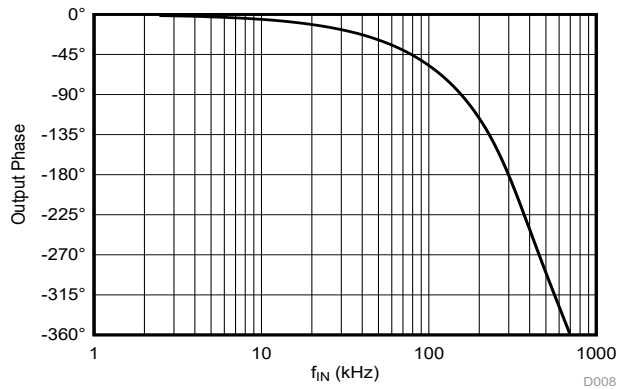


图 6-35. Output Phase vs Input Frequency

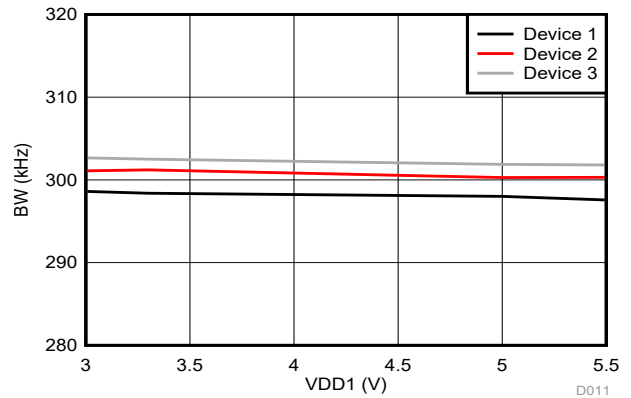


图 6-36. Bandwidth vs Supply Voltage

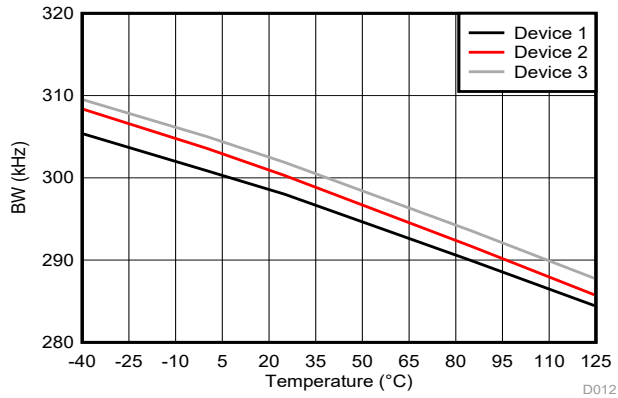


图 6-37. Bandwidth vs Temperature

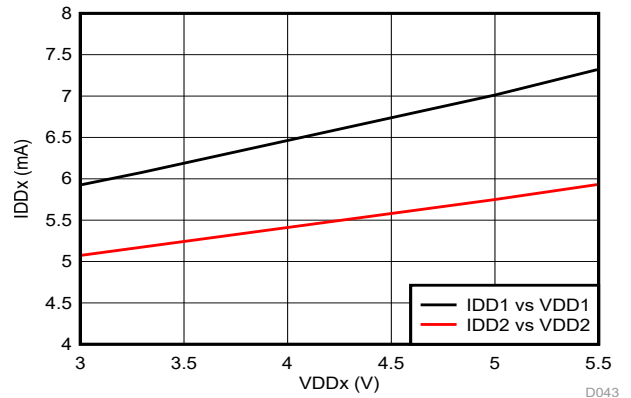


图 6-38. Supply Current vs Supply Voltage

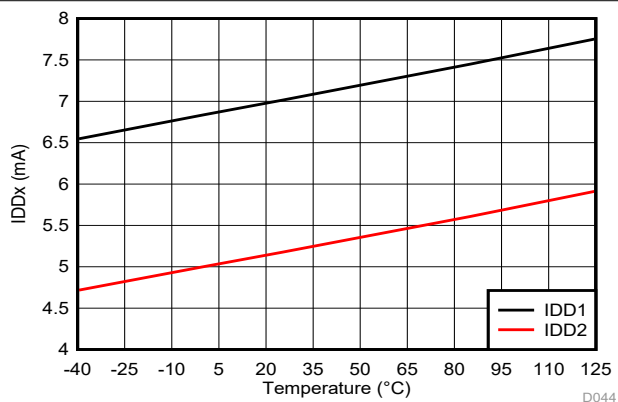


图 6-39. Supply Current vs Temperature

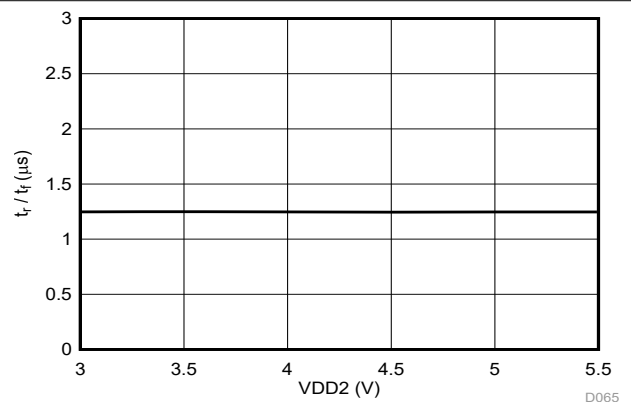


图 6-40. Output Rise and Fall Time vs Supply Voltage

## 6.13 Typical Characteristics (continued)

at VDD1 = 5 V, VDD2 = 3.3 V, IN = 0 V to 5 V, and  $f_{IN} = 10$  kHz (unless otherwise noted)

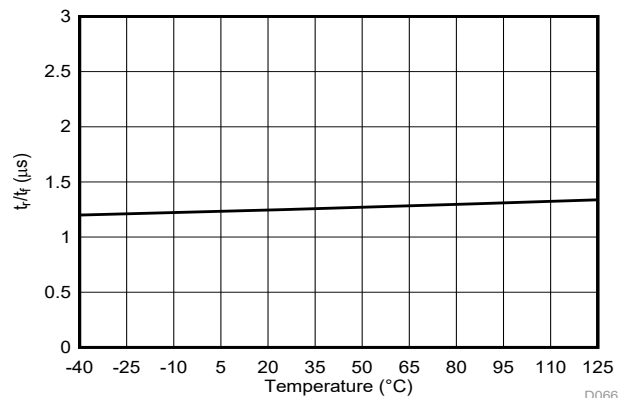


图 6-41. Output Rise and Fall Time vs Temperature

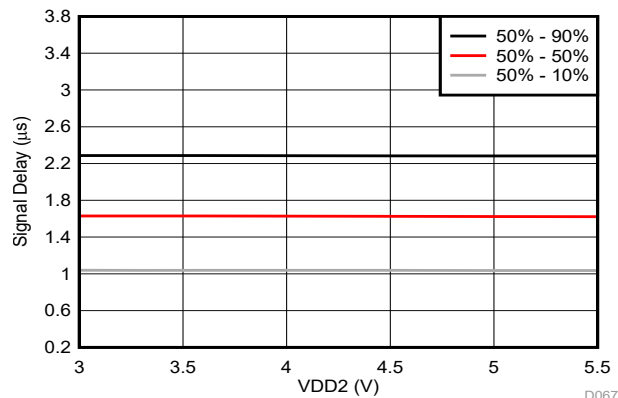


图 6-42. Input to Output Signal Delay vs Supply Voltage

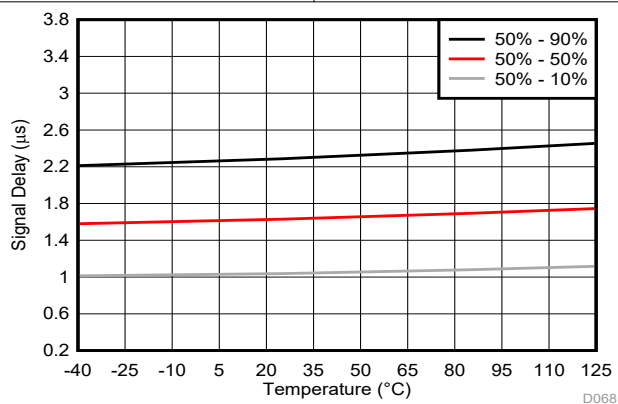


图 6-43. Input to Output Signal Delay vs Temperature

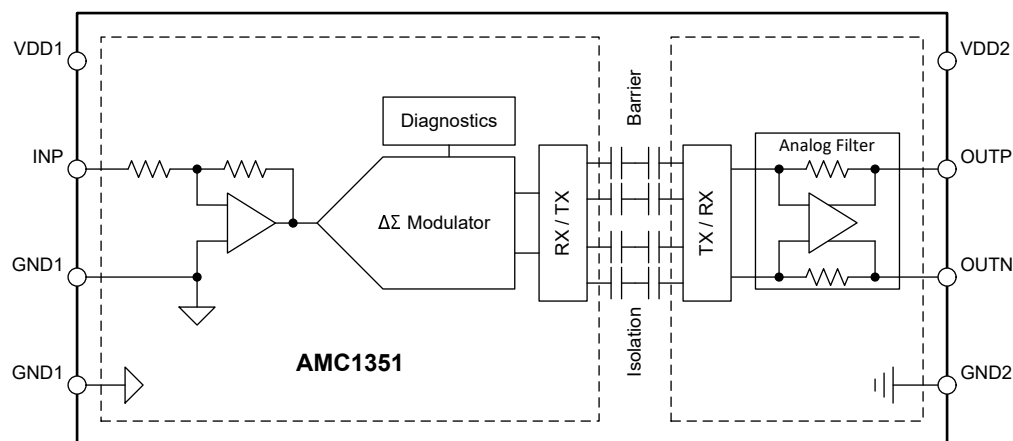
## 7 Detailed Description

### 7.1 Overview

The AMC1351 is a single-ended input, precision, isolated amplifier with a high input-impedance and wide input-voltage range. The input stage of the device drives a second-order, delta-sigma ( $\Delta\Sigma$ ) modulator. The modulator converts the analog input signal into a digital bitstream that is transferred across the isolation barrier that separates the high-side from the low-side. On the low-side, the received bitstream is processed by a fourth-order analog filter that outputs a differential signal at the OUTP and OUTN pins proportional to the input signal.

The SiO<sub>2</sub>-based, capacitive isolation barrier supports a high level of magnetic field immunity, as described in the [ISO72x Digital Isolator Magnetic-Field Immunity application report](#). The digital modulation used in the AMC1351 to transmit data across the isolation barrier, and the isolation barrier characteristics itself, result in high reliability and common-mode transient immunity.

### 7.2 Functional Block Diagram



### 7.3 Feature Description

#### 7.3.1 Analog Input

The single-ended, high-impedance input stage of the AMC1351 feeds a second-order, switched-capacitor, feed-forward  $\Delta\Sigma$  modulator. The modulator converts the analog signal into a bitstream that is transferred across the isolation barrier, as described in the [Isolation Channel Signal Transmission](#) section.

There are two restrictions on the analog input signal IN. First, if the input voltage  $V_{IN}$  exceeds the range specified in the [Absolute Maximum Ratings](#) table, the input current must be limited to the absolute maximum value because the electrostatic discharge (ESD) protection turns on. In addition, the linearity and parametric performance of the device is ensured only when the analog input voltage remains within the linear full-scale range ( $V_{FSR}$ ) as specified in the [Recommended Operating Conditions](#) table.

### 7.3.2 Isolation Channel Signal Transmission

The AMC1351 uses an on-off keying (OOK) modulation scheme, as shown in 图 7-1, to transmit the modulator output bitstream across the SiO<sub>2</sub>-based isolation barrier. The transmit driver (TX) shown in the [Functional Block Diagram](#) transmits an internally-generated, high-frequency carrier across the isolation barrier to represent a digital *one* and does not send a signal to represent a digital *zero*. The nominal frequency of the carrier used inside the AMC1351 is 480 MHz.

The receiver (RX) on the other side of the isolation barrier recovers and demodulates the signal and provides the input to the fourth-order analog filter. The AMC1351 transmission channel is optimized to achieve the highest level of common-mode transient immunity (CMTI) and lowest level of radiated emissions caused by the high-frequency carrier and RX, TX buffer switching.

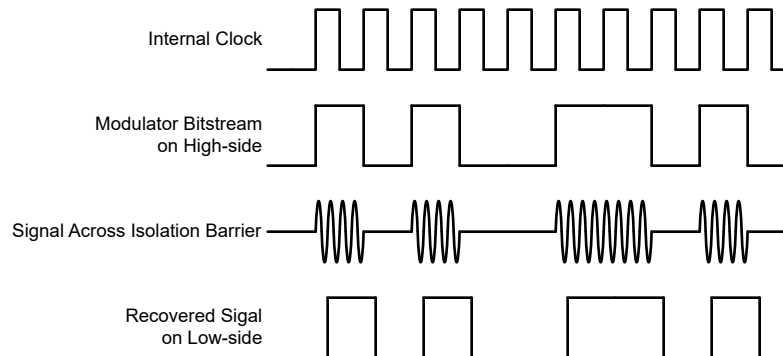
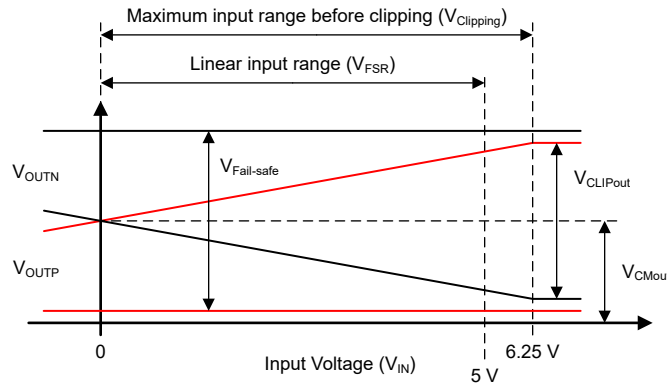


图 7-1. OOK-Based Modulation Scheme

### 7.3.3 Analog Output

The AMC1351 provides a differential analog output on the OUTP and OUTN pins. For input voltages ( $V_{IN}$ ) in the range from  $-0.25$  V to  $5$  V, the device provides a linear response with a nominal gain of  $0.4$  V/V. For example, for an input voltage of  $5$  V, the differential output voltage ( $V_{OUTP} - V_{OUTN}$ ) is  $2$  V. At zero input (IN shorted to GND1), both pins output the same common-mode output voltage  $V_{CMout}$ , as specified in the [Electrical Characteristics](#) table. For input voltages greater than  $5$  V but less than approximately  $6.25$  V, the differential output voltage continues to increase but with reduced linearity performance. The outputs saturate at a differential output voltage of  $V_{CLIPout}$ , as shown in [Figure 7-2](#), if the input voltage exceeds the  $V_{Clipping}$  value.



**图 7-2. Output Behavior of the AMC1351**

The AMC1351 output offers a fail-safe feature that simplifies diagnostics on a system level. [Figure 7-2](#) shows the behavior in fail-safe mode, in which the AMC1351 outputs a negative differential output voltage that does not occur under normal operating conditions. The fail-safe output is active:

- When the high-side supply VDD1 of the AMC1351 device is missing
- When the high-side supply VDD1 falls below the undervoltage threshold  $VDD1_{UV}$

Use the maximum  $V_{Fail-safe}$  voltage specified in the [Electrical Characteristics](#) table as a reference value for fail-safe detection on a system level.

### 7.4 Device Functional Modes

The AMC1351 is operational when the power supplies VDD1 and VDD2 are applied as specified in the [Recommended Operating Conditions](#) table.

## 8 Application and Implementation

### 备注

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

### 8.1 Application Information

The high input impedance, low input bias current, excellent accuracy, and low temperature drift make the AMC1351 a high-performance solution for industrial applications where voltage sensing in the presence of high common-mode voltage levels is required.

### 8.2 Typical Application

Isolated amplifiers are widely used for voltage measurements in high-voltage applications that must be isolated from a low-voltage domain. A typical application is the sensing of the DC bus voltage in a frequency inverter.

With its wide, 5-V input voltage range, the AMC1351 is designed for isolated DC voltage-sensing applications where accurate voltage monitoring is required in high-noise environments.

图 8-1 shows a simplified schematic of the AMC1351 in a typical motor drive application. The DC bus voltage is divided down to an approximate 5-V level across the bottom resistor (RSNS) of a high-impedance resistor divider that is sensed by the AMC1351. The AMC1351 digitizes the analog input signal on the high-side, transfers the data across the isolation barrier to the low-side, and reconstructs an analog signal that is presented as a differential voltage on the output pins.

The high-impedance input and the high common-mode transient immunity (CMTI) of the AMC1351 ensure reliable and accurate operation even in high-noise environments.

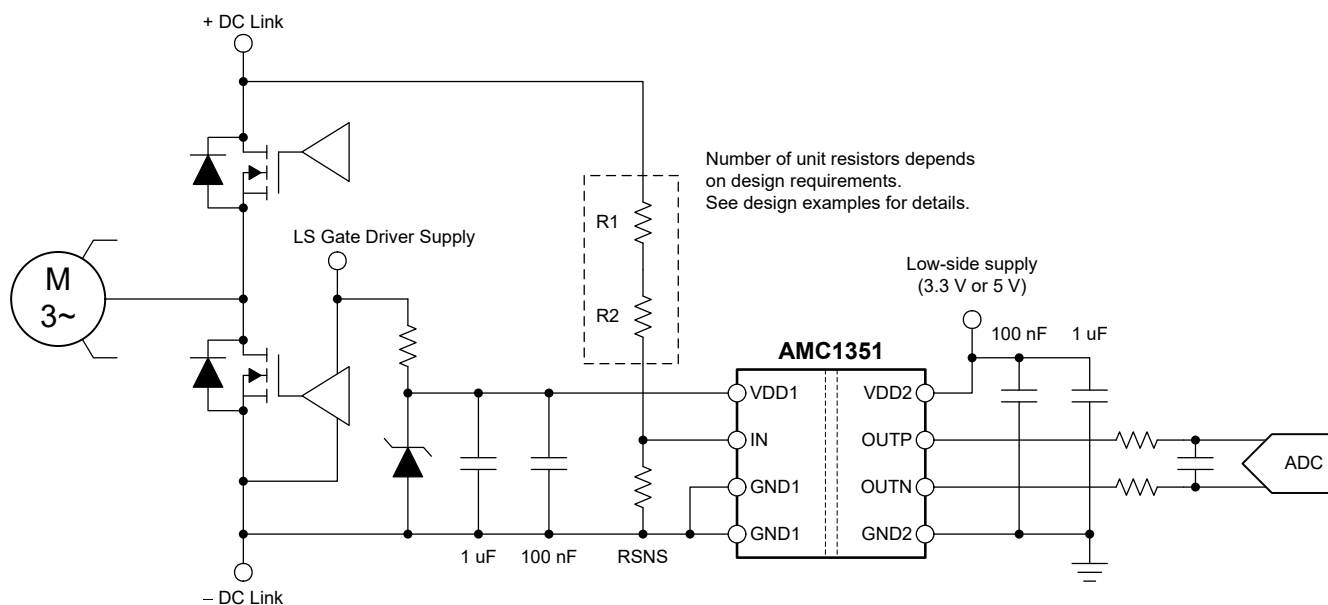


图 8-1. Using the AMC1351 for DC Link Voltage Sensing in Frequency Inverters

## 8.2.1 Design Requirements

表 8-1 lists the parameters for this typical application.

表 8-1. Design Requirements

| PARAMETER                                                           | 190-V <sub>DC</sub> LINE VOLTAGE | 360-V <sub>DC</sub> LINE VOLTAGE |
|---------------------------------------------------------------------|----------------------------------|----------------------------------|
| System input voltage                                                | 120 V <sub>RMS</sub> ±10%, 60 Hz | 230 V <sub>RMS</sub> ±10%, 50 Hz |
| DC bus voltage (max)                                                | 190 V                            | 360 V                            |
| High-side supply voltage                                            | 3.3 V or 5 V                     | 3.3 V or 5 V                     |
| Low-side supply voltage                                             | 3.3 V or 5 V                     | 3.3 V or 5 V                     |
| Maximum resistor operating voltage                                  | 75 V                             | 75 V                             |
| Voltage drop across the sense resistor (RSNS) for a linear response | 5 V (maximum)                    | 5 V (maximum)                    |
| Current through the resistive divider (I <sub>CROSS</sub> )         | 100 μA                           | 100 μA                           |

## 8.2.2 Detailed Design Procedure

This discussion covers the 360-V<sub>DC</sub> example. The procedure for calculating the resistive divider for the 190-V<sub>DC</sub> use case is identical.

The 100-μA, cross-current requirement at peak input voltage (360 V) determines that the total impedance of the resistive divider is 3.6 MΩ. The impedance of the resistive divider is dominated by the top resistors (shown exemplary as R1 and R2 in 图 8-1) and the voltage drop across RSNS can be neglected for a short time. The maximum allowed voltage drop per unit resistor is specified as 75 V; therefore, the total minimum number of unit resistors in the top portion of the resistive divider is 360 V / 75 V = 5. The calculated unit value is 3.6 MΩ / 5 = 720 kΩ and the next closest value from the E96 series is 715 kΩ.

The *effective* sense resistor value RSNS<sub>EFF</sub> is the parallel combination of the external resistor RSNS and the input impedance of the AMC1351, R<sub>IN</sub>. RSNS<sub>EFF</sub> is sized such that the voltage drop across the impedance at maximum input voltage (360 V) equals the linear full-scale input voltage (V<sub>FSR</sub>) of the AMC1351 (that is, 5 V). RSNS<sub>EFF</sub> is calculated as  $RSNS_{EFF} = V_{FSR} / (V_{Peak} - V_{FSR}) \times R_{TOP}$ , where R<sub>TOP</sub> is the total value of top resistor string (5 × 715 kΩ = 3575 kΩ). The resulting value for RSNS<sub>EFF</sub> is 9.96 kΩ. In a final step, RSNS is calculated as  $RSNS = R_{IN} \times RSNS_{EFF} / (R_{IN} - RSNS_{EFF})$ . With R<sub>IN</sub> = 1.25 MΩ (typical), RSNS equals 52.47 kΩ and the next closest value from the E96 series is 52.3 kΩ.

表 8-2 summarizes the design of the resistive divider.

表 8-2. Resistor Value Examples

| PARAMETER                                                         | 190-V <sub>DC</sub> LINE VOLTAGE | 360-V <sub>DC</sub> LINE VOLTAGE |
|-------------------------------------------------------------------|----------------------------------|----------------------------------|
| Unit resistor value (R <sub>TOP</sub> )                           | 634 kΩ                           | 715 kΩ                           |
| Number of unit resistors in R <sub>TOP</sub>                      | 3                                | 5                                |
| Sense resistor value (RSNS)                                       | 51.1 kΩ                          | 49.9 kΩ                          |
| Total resistance value (R <sub>TOP</sub> + RSNS)                  | 1953.1 kΩ                        | 3624.9 kΩ                        |
| Resulting current through resistive divider (I <sub>CROSS</sub> ) | 97.3 μA                          | 99.3 μA                          |
| Resulting full-scale voltage drop across sense resistor RSNS      | 4.971 V                          | 4.956 V                          |
| Peak power dissipated in R <sub>TOP</sub> unit resistors          | 6 mW                             | 7.1 mW                           |
| Total peak power dissipated in resistive divider                  | 18.5 mW                          | 35.8 mW                          |

### 8.2.2.1 Input Filter Design

Placing an RC filter in front of the isolated amplifier improves signal-to-noise performance of the signal path. In practice, however, the impedance of the resistor divider is so high that adding a filter capacitor on the IN pin limits the signal bandwidth to an unacceptable low limit, such that the filter capacitor is omitted. When used, design the input filter such that:

- The cutoff frequency of the filter is at least one order of magnitude lower than the sampling frequency (20 MHz) of the internal  $\Delta \Sigma$  modulator
- The input bias current does not generate significant voltage drop across the DC impedance of the input filter

Most voltage-sensing applications use high-impedance resistor dividers in front of the isolated amplifier to scale down the input voltage. In that case, no additional resistor is needed and a single capacitor (as shown in [Figure 8-2](#)) is sufficient to filter the input signal.

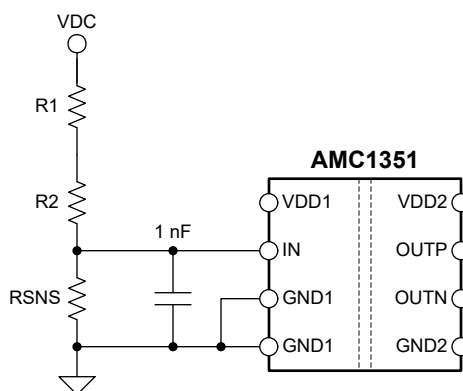


图 8-2. Input Filter

### 8.2.2.2 Differential to Single-Ended Output Conversion

[Figure 8-3](#) shows an example of a **TLV6001**-based signal conversion and filter circuit for systems using single-ended input ADCs to convert the analog output voltage into digital. With  $R1 = R2 = R3 = R4$ , the output voltage equals  $(V_{OUTP} - V_{OUTN}) + V_{REF}$ . Tailor the bandwidth of this filter stage to the bandwidth requirement of the system and use NP0-type capacitors for best performance. For most applications,  $R1 = R2 = R3 = R4 = 3.3 \text{ k}\Omega$  and  $C1 = C2 = 330 \text{ pF}$  yields good performance.

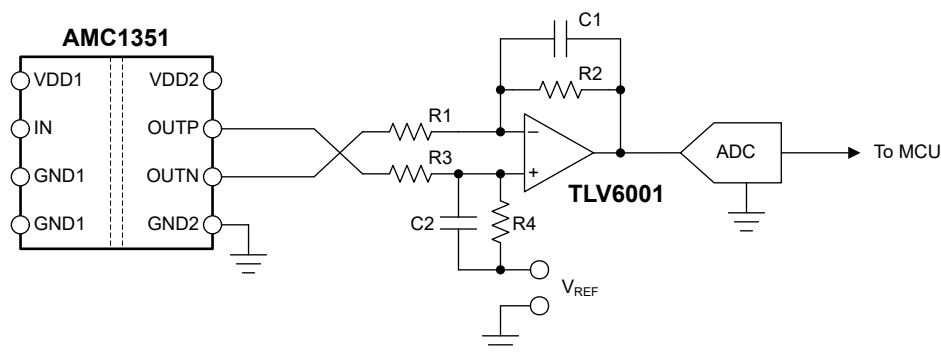


图 8-3. Connecting the AMC1351 Output to a Single-Ended Input ADC

For more information on the general procedure to design the filtering and driving stages of SAR ADCs, see the [18-Bit, 1MSPS Data Acquisition Block \(DAQ\) Optimized for Lowest Distortion and Noise](#) and [18-Bit Data Acquisition Block \(DAQ\) Optimized for Lowest Power](#) reference guides, available for download at [www.ti.com](http://www.ti.com).

### 8.2.3 Application Curve

One important aspect of system design is the effective detection of an overvoltage condition to protect switching devices and passive components from damage. To power off the system quickly in the event of an overvoltage condition, a low delay caused by the isolated amplifier is required. 图 8-4 shows the typical full-scale step response of the AMC1351.

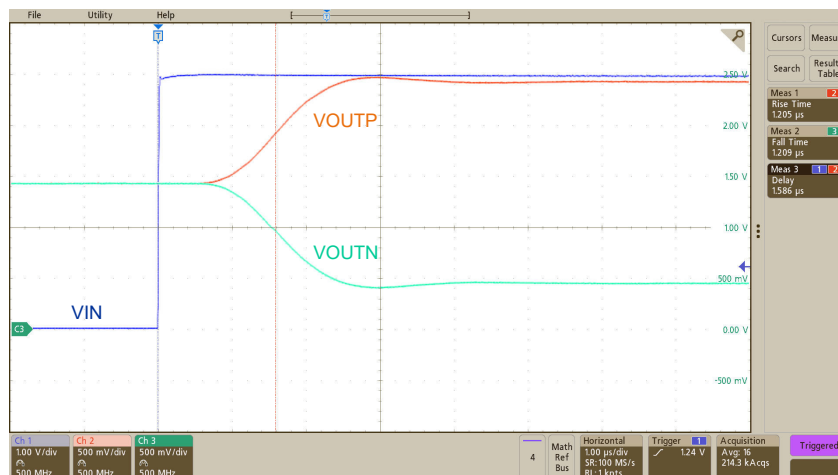


图 8-4. Step Response of the AMC1351

### 8.3 What To Do and What Not To Do

Do not leave the analog input (IN) of the AMC1351 unconnected (floating) when the device is powered up on the high-side. If the device input is left floating, the bias current may generate a positive or negative input voltage and the output of the device is undetermined.

Do not connect protection diodes to the input (IN) of the AMC1351. Diode leakage current can introduce significant measurement error especially at high temperatures. The input pin is protected against high voltages by its ESD protection circuit and the high impedance of the external resistive divider

Connect both GND1 pins to the high-side ground potential. Do not leave one of the GND1 pins unconnected.

## 9 Power Supply Recommendations

In a typical application, the high-side power supply (VDD1) for the AMC1351 is generated either from a gate-driver supply on the high-side (as shown in 图 8-1), or from the low-side supply (VDD2) by an isolated DC/DC converter. A low-cost solution is based on the push-pull driver SN6501 and a transformer that supports the desired isolation voltage ratings.

The AMC1351 does not require any specific power-up sequencing. The high-side power supply (VDD1) is decoupled with a low-ESR, 100-nF capacitor (C1) parallel to a low-ESR, 1- $\mu$ F capacitor (C2). The low-side power supply (VDD2) is equally decoupled with a low-ESR, 100-nF capacitor (C3) parallel to a low-ESR, 1- $\mu$ F capacitor (C4). Place all four capacitors (C1, C2, C3, and C4) as close to the device as possible.

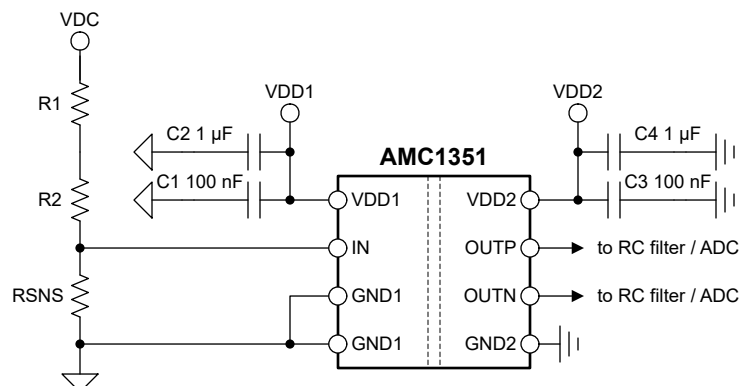


图 9-1. Decoupling of the AMC1351

Capacitors must provide adequate effective capacitance under the applicable DC bias conditions they experience in the application. Multilayer ceramic capacitors (MLCC) typically exhibit only a fraction of their nominal capacitance under real-world conditions and this factor must be taken into consideration when selecting these capacitors. This problem is especially acute in low-profile capacitors, in which the dielectric field strength is higher than in taller components. Reputable capacitor manufacturers provide capacitance versus DC bias curves that greatly simplify component selection.

## 10 Layout

### 10.1 Layout Guidelines

Figure 10-1 shows a layout recommendation with the critical placement of the decoupling capacitors (as close as possible to the AMC1351 supply pins) and placement of the other components required by the device. For best performance, place the sense resistor close to the device input pin (IN).

### 10.2 Layout Example

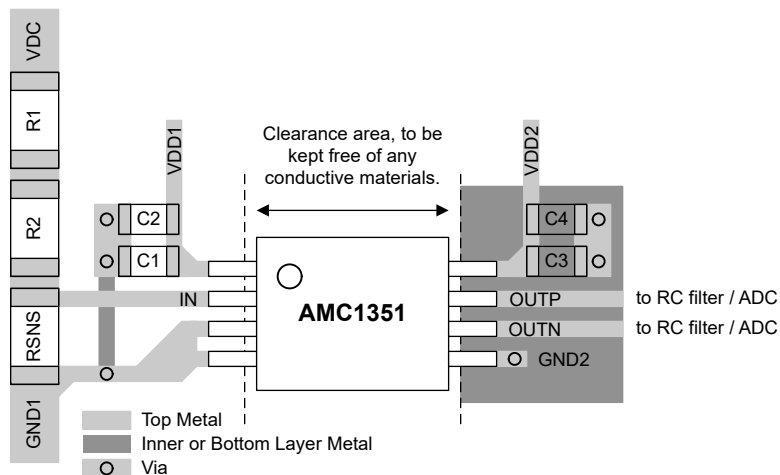


Figure 10-1. Recommended Layout of the AMC1351

## 11 Device and Documentation Support

### 11.1 Documentation Support

#### 11.1.1 Related Documentation

For related documentation, see the following:

- Texas Instruments, [Isolation Glossary application report](#)
- Texas Instruments, [Semiconductor and IC Package Thermal Metrics application report](#)
- Texas Instruments, [ISO72x Digital Isolator Magnetic-Field Immunity application report](#)
- Texas Instruments, [TLV600x Low-Power, Rail-to-Rail In/Out, 1-MHz Operational Amplifier for Cost-Sensitive Systems data sheet](#)
- Texas Instruments, [18-Bit, 1-MSPS Data Acquisition Block \(DAQ\) Optimized for Lowest Distortion and Noise reference guide](#)
- Texas Instruments, [18-Bit, 1-MSPS Data Acquisition Block \(DAQ\) Optimized for Lowest Power reference guide](#)
- Texas Instruments, [Isolated Amplifier Voltage Sensing Excel Calculator design tool](#)
- Texas Instruments, [Best in Class Radiated Emissions EMI Performance with the AMC1300B-Q1 Isolated Amplifier technical white paper](#)

#### 11.2 接收文档更新通知

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链接的内容由各个贡献者“按原样”提供。这些内容并不构成 TI 技术规范，并且不一定反映 TI 的观点；请参阅 TI 的《使用条款》。

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ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### 11.6 术语表

**TI 术语表** 本术语表列出并解释了术语、首字母缩略词和定义。

## 12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

## PACKAGING INFORMATION

| Orderable part number       | Status<br>(1) | Material type<br>(2) | Package   Pins | Package qty   Carrier | RoHS<br>(3) | Lead finish/<br>Ball material<br>(4) | MSL rating/<br>Peak reflow<br>(5) | Op temp (°C) | Part marking<br>(6) |
|-----------------------------|---------------|----------------------|----------------|-----------------------|-------------|--------------------------------------|-----------------------------------|--------------|---------------------|
| <a href="#">AMC1351DWV</a>  | Active        | Production           | SOIC (DWV)   8 | 64   TUBE             | Yes         | NIPDAU                               | Level-3-260C-168 HR               | -40 to 125   | AMC1351             |
| AMC1351DWV.A                | Active        | Production           | SOIC (DWV)   8 | 64   TUBE             | Yes         | NIPDAU                               | Level-3-260C-168 HR               | -40 to 125   | AMC1351             |
| <a href="#">AMC1351DWVR</a> | Active        | Production           | SOIC (DWV)   8 | 1000   LARGE T&R      | Yes         | NIPDAU                               | Level-3-260C-168 HR               | -40 to 125   | AMC1351             |
| AMC1351DWVR.A               | Active        | Production           | SOIC (DWV)   8 | 1000   LARGE T&R      | Yes         | NIPDAU                               | Level-3-260C-168 HR               | -40 to 125   | AMC1351             |
| AMC1351DWVRG4               | Active        | Production           | SOIC (DWV)   8 | 1000   LARGE T&R      | Yes         | NIPDAU                               | Level-3-260C-168 HR               | -40 to 125   | AMC1351             |
| AMC1351DWVRG4.A             | Active        | Production           | SOIC (DWV)   8 | 1000   LARGE T&R      | Yes         | NIPDAU                               | Level-3-260C-168 HR               | -40 to 125   | AMC1351             |

<sup>(1)</sup> **Status:** For more details on status, see our [product life cycle](#).

<sup>(2)</sup> **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

<sup>(4)</sup> **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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**OTHER QUALIFIED VERSIONS OF AMC1351 :**

- Automotive : [AMC1351-Q1](#)

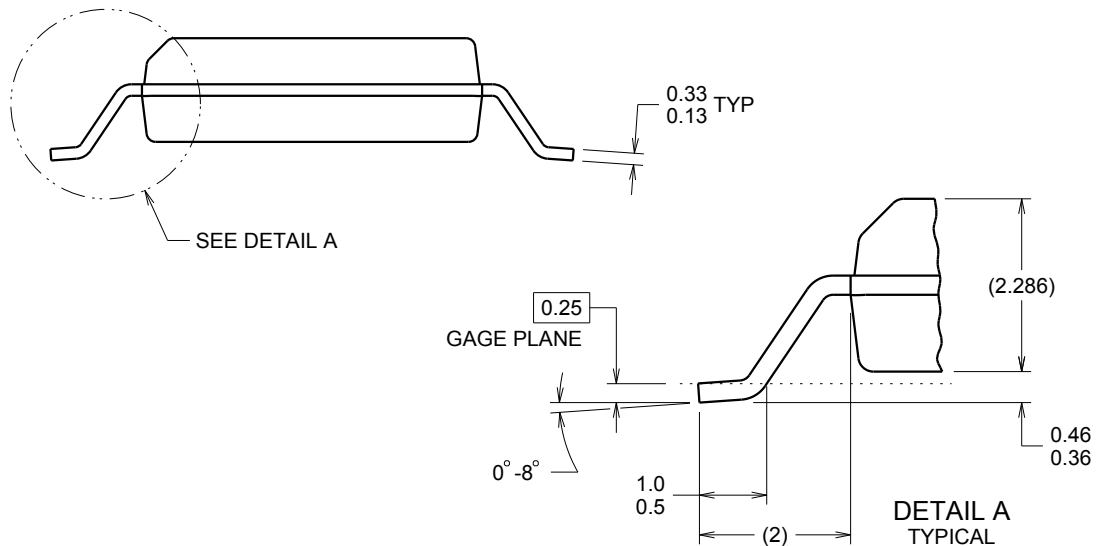
NOTE: Qualified Version Definitions:

- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

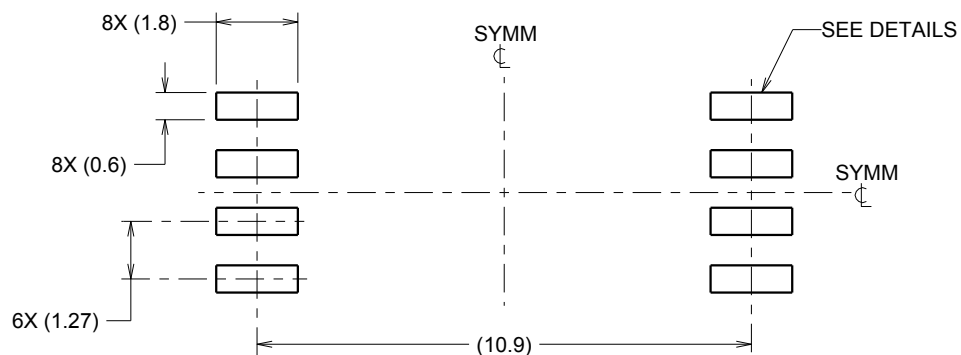


SOIC - 2.8 mm max height

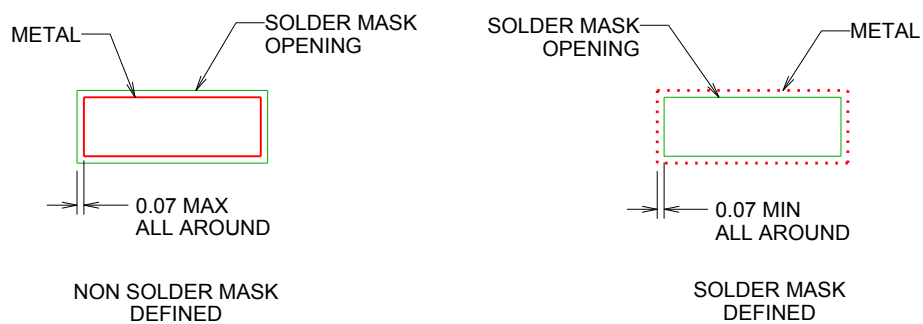
PIN 1 ID AREA  
 11.5 ± 0.25 TYP  
 5.95  
 5.75  
 NOTE 3  
 1  
 4  
 8  
 5  
 6X 1.27  
 2X 3.81  
 8X 0.51  
 0.31  
 7.6  
 7.4  
 NOTE 4  
 A  
 B  
 SEATING PLANE  
 0.1 C  
 2.8 MAX  
 C  
 A  
 B  
 S



1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm, per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm, per side.



LAND PATTERN EXAMPLE  
9.1 mm NOMINAL CLEARANCE/CREEPAGE  
SCALE:6X

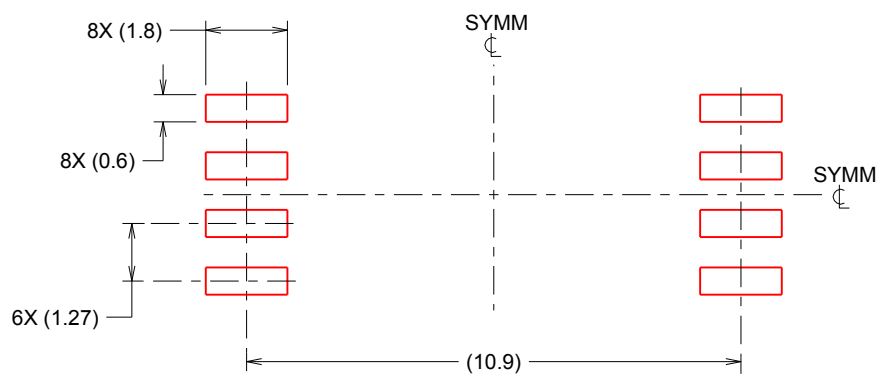


SOLDER MASK DETAILS

4218796/A 09/2013

NOTES: (continued)

5. Publication IPC-7351 may have alternate designs.
6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOLDER PASTE EXAMPLE  
 BASED ON 0.125 mm THICK STENCIL  
 SCALE:6X

4218796/A 09/2013

NOTES: (continued)

7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
8. Board assembly site may have different recommendations for stencil design.

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